Sheet 1 (A) of 2

SUBSTITUTE (MODIFIED)	FIED) U.S. DEPARTMENT OF PATENT AND TRADEM														SERIAL NO. 10/784,445	
MAY	0 3 2004	1.5.							OSURE LICANT			APPLICANT Devoe et al.				
(37 CT 2,1,98		\$	(Us	e se	ver	al st	reet	s if ne	ecessary)		FILING DATE February 23, 2004				GROUP Unknown	
	CF.								U.S. F	PATENT D	OCUMENTS					
EXAMINER INITIAL		PATENT NUMBER DATE F										•	CLASS SUBCLASS		LASS	FILING DATE IF APPROPRIATE
NOW	A.A	4	3	4.	8	7	1	4	09/07/1982	Wallace			361	328		11/14/1980
Men	A.B	4	3	9	5	2	3	1	07/26/1983	Sands et	t al.		432	11		10/30/1981
MOU	A.C	4	4	7	5	9	6	7	10/08/1984	Kanai et	al.		156	89		08/04/1983
Man	A.D	4	5	6	2	1	2	4	12/31/1985	Ruka	-		429	30		01/22/1985
MCM	A.E	4	5	7	9	7	0	7	04/01/1986	Kobayas	shi et al.		264	209.1		06/27/1983
Man	A.F	4	7	7	0	6	3	1	09/13/1988	Hell et al	l.		432	258		06/30/1987
Mon	A.G	4	9	8	5	1	0	3	01/15/1991	Kouno et	t al.		156	184		12/13/1989
you	A.H	5	1	0	8	8	5	0	04/28/1992	Carlson (et al.		429	31		08/01/1990
May	A.I	5	1	5	1	6	6	0 .	09/29/1992	Powers e	et al.		324	689		09/05/1990
Исщ	A.J	5	2	2	7	1	0	5	07/13/1993	Eucker e	et al.		264	57		07/09/1990
Исш	A.K	5	2	7	7	9	9	5	01/11/1994	Ruka et a	al.		429	31		03/16/1993
	FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS															
		DOCUMENT PUBLICATION NUMBER DATE									COUNTRY OR PATENT OFFICE CLASS			SUBCLASS		TRANSLATION (YES/NO)
ucy	A.L	JP 62-292646 12/19/1987 JP											C03B	32/00		Abstract
acu	A.M	JP 64-025583 01/27/1989 JP								JP		H01L 41		41/22	Abstract	
<u> ч</u> си	A.N	JP 3233915 10/17/1991 JP							17/1991	JP	H01F 41/0			41/04		Abstract
Mcu	A.O	JP 7226317 08/22/1995 J							22/1995	JP .	JP H01F			6/06 A		Abstract
	A.P									- -						
	A.Q							L		Д						
									JMENTS (Incl.					-		
ncu	A.R	A.R Henrik Raeder, <u>Fabrication of thin-walled ceramic tubes by tape casting</u> , Ceramics Today-Tomorrow's Ceramics, Elsevier Science Publishers, 1991, p. 1123-1129												eramics, Elsevier		
deu.	A.S	S <u>Improved construction of bender element</u> , IBM Technical Disclosure Bulletin, Jun. 1986, vol. 29, p. 28-31											1			
	A.T															
EXAMINER Mayor DATE CONSIDERED 4/1/05																
EXAMINER: I	nitial if cit	ation	EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance and not considered. Include a copy of this form with next communication to Applicant.													

Sheet 2 (B) of 2																	
SUBSTITUTE (MODIFIED)	UBSTITUTE FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE												ATTY. DOCKET NO. DEVOE-26			SERIAL NO. 10/784,445	
MAY 0	3 2004	CE 31							OSURE LICANT	APPLICANT Devoe et al.							
(37 CPR 4-98)	7 CPR (98(b)) (Use several sheets if necessary)														GROUP Unknown		
	٠. مساه								U.S. F	PATENT	DOCUMENTS			<u> </u>			
EXAMINER INITIAL			PA	TEN	4 TI	IU M	BEF	₹	ISSUE DATE		CLASS	SUBC	FILING DATE IF APPROPRIATE				
More	B.A	5 7 7 9 9 6 9 07/14/1998 Chatterjee et al.							Chatte		264	619		06/20/1997			
May	8.8	5	9	3	5	5	1	3	09/10/1999	Martreu	uil et al.		264	608		01/14/1998	
Man	B.C	6	6	6 9 5 9 4 0 02/24/2004 Devoe et al.						et al.		156	89.11		04/05/2001		
	B.D																
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OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)																	
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